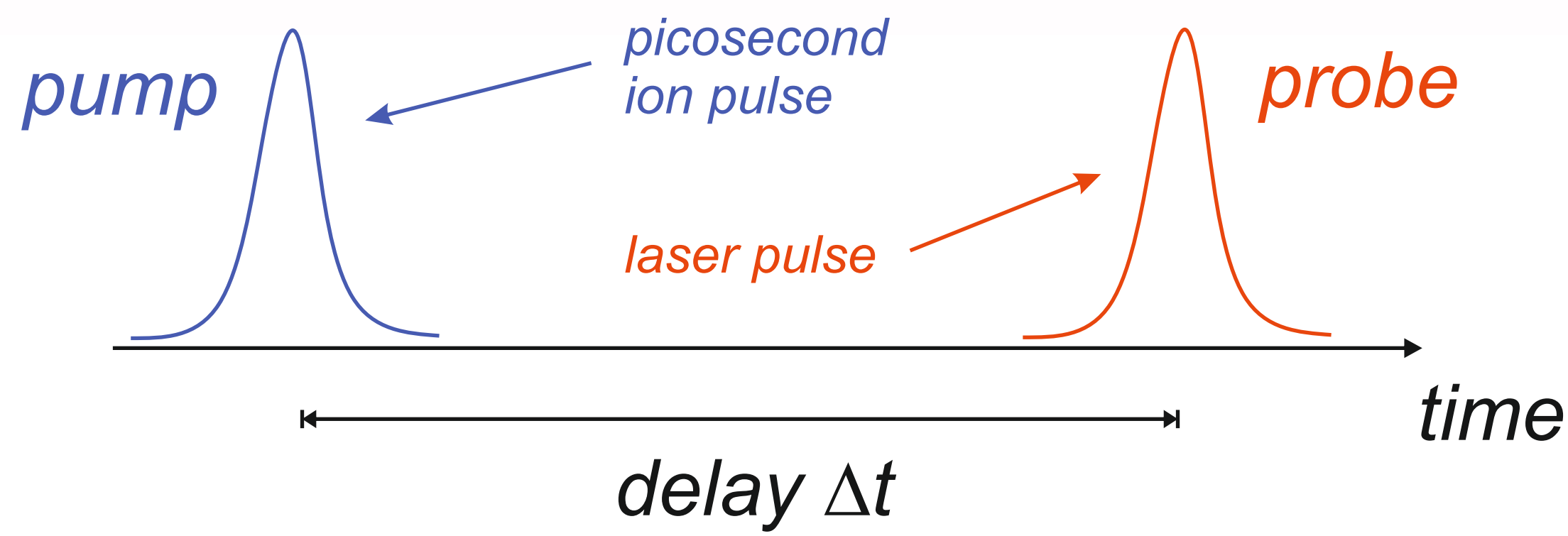


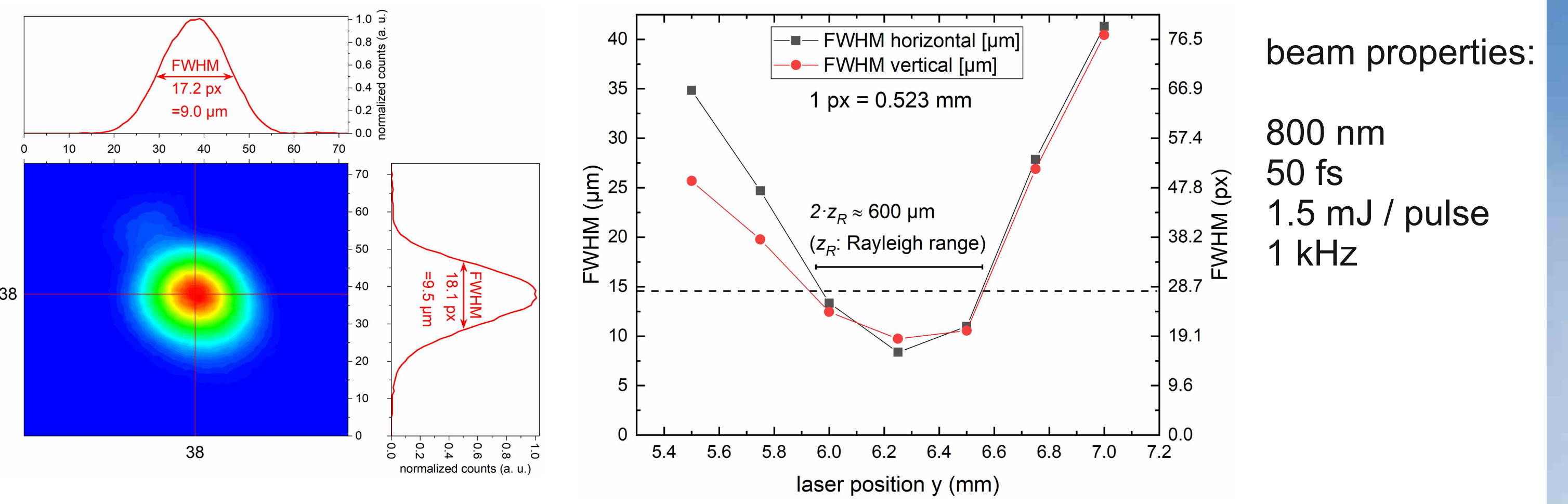
Motivation

- Can we generate ion pulses of picosecond time resolution in the keV-range for observation of ultra-short dynamics via pump-probe technique?



- generation of ultra-short ion pulses: difficult task due to space-charge broadening and velocity distribution of ions at a given temperature
- ⇒ supersonic gas expansion - control over number density and temperature distribution
- characterization of such a supersonic gas expansion of Argon via Excimer laser

Characterization of fs photoionization laser



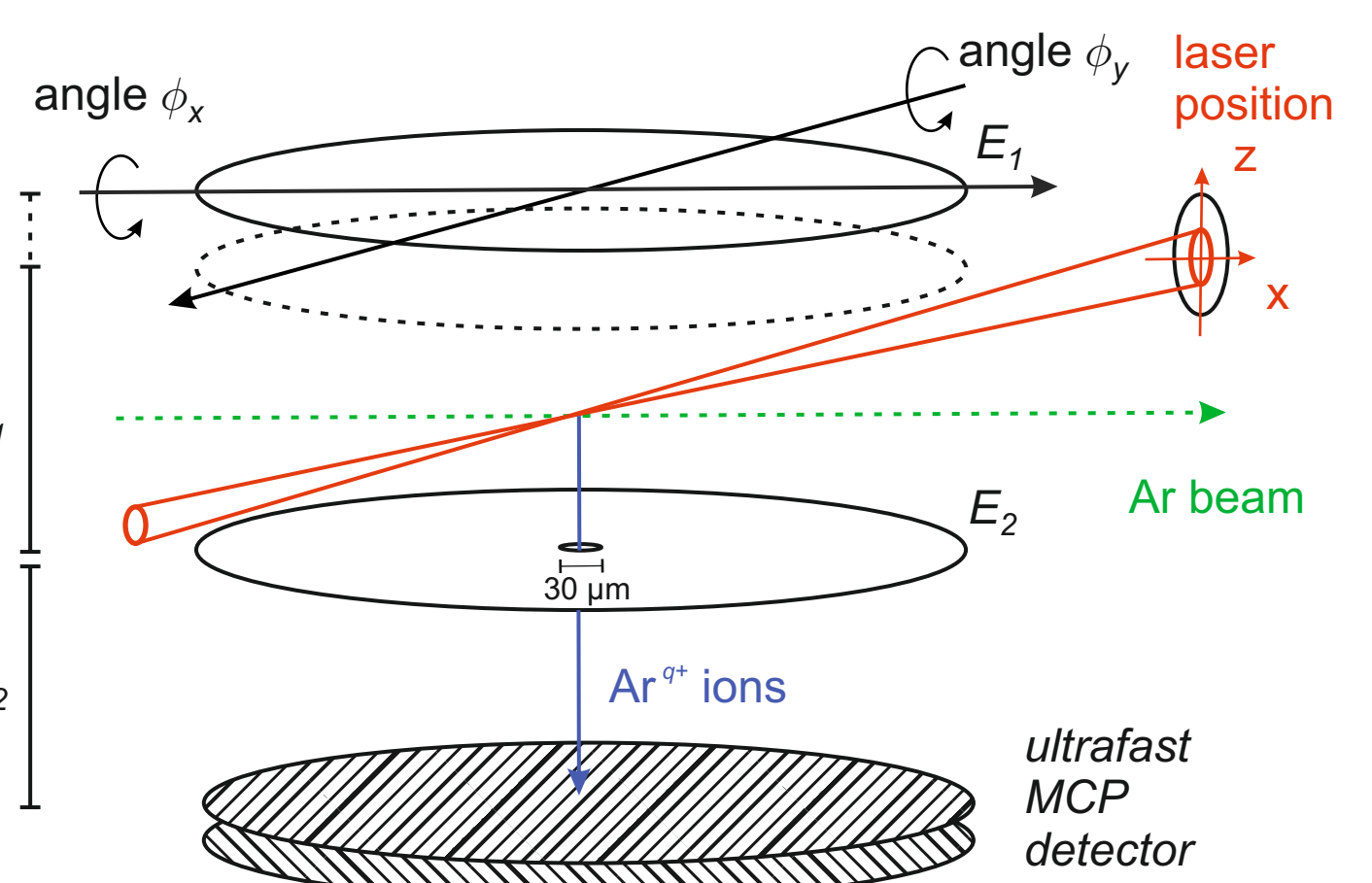
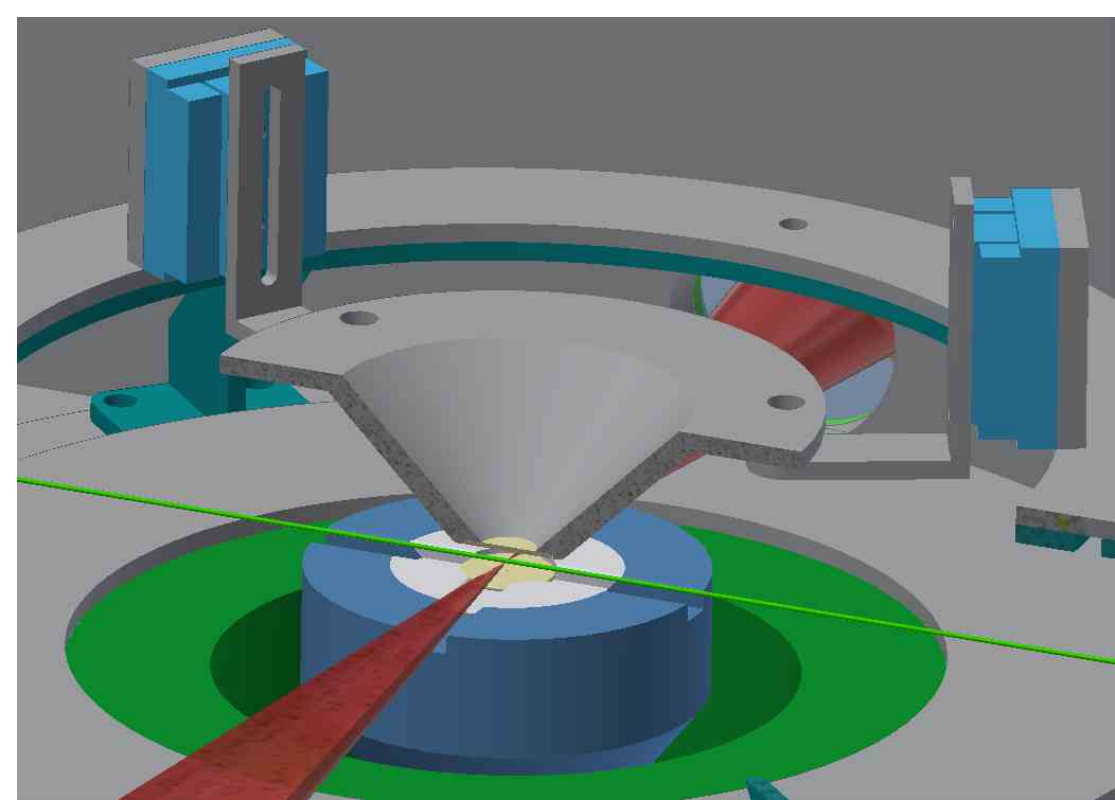
beam properties:

800 nm
50 fs
1.5 mJ / pulse
1 kHz

- nearly symmetrical laser spot profile with diameter < 10 μm and Rayleigh range of $z_R \approx 300 \mu\text{m}$
- measured spot profile leads to a maximum peak intensity $I_0 \approx 3.5 \times 10^{16} \text{ W/cm}^2$
- ⇒ intensity allows in principle to create Ar^{q+} with charge state $q = 1, \dots, 6$

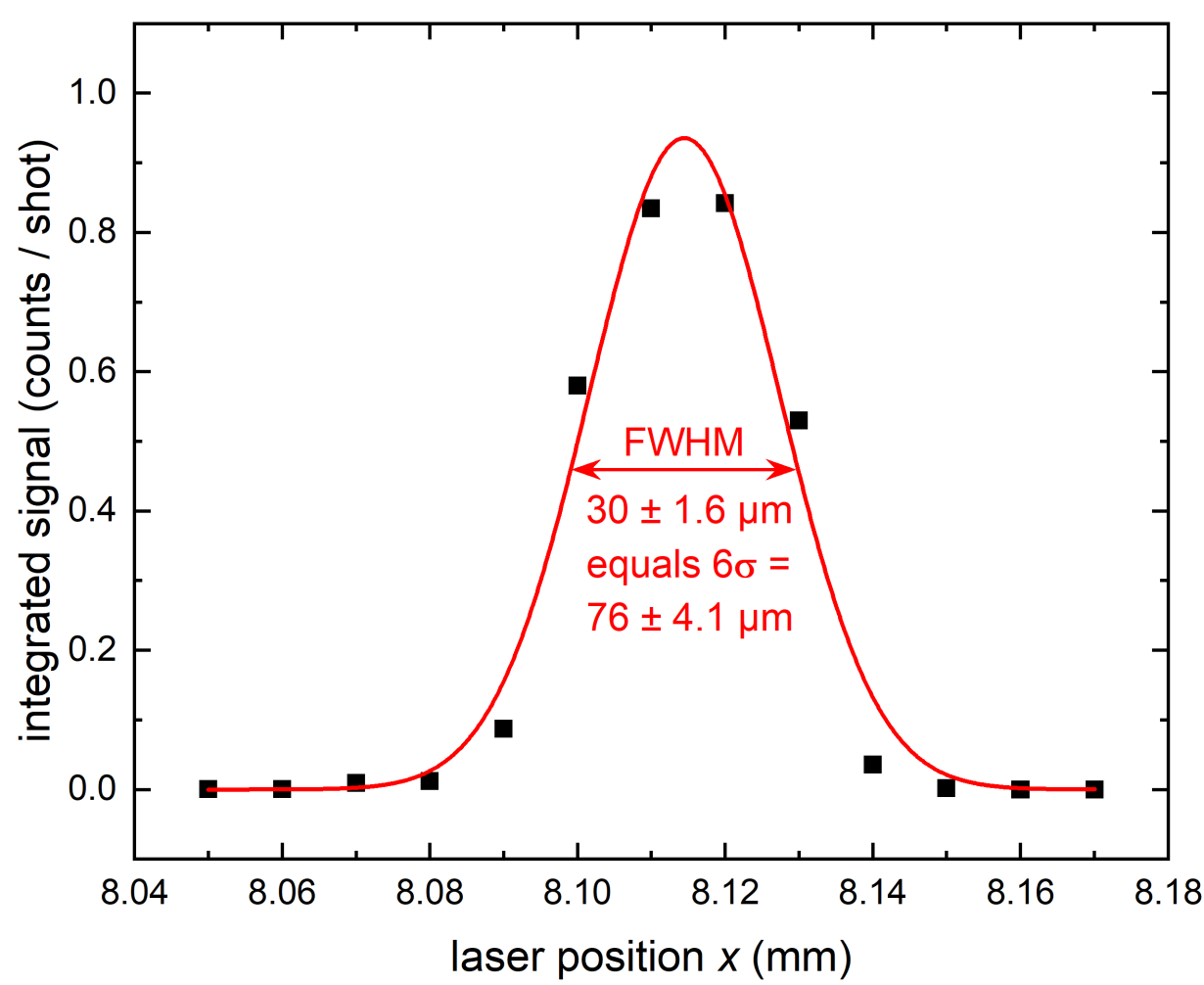
Characterization of buncher geometry with Argon

Experimental setup

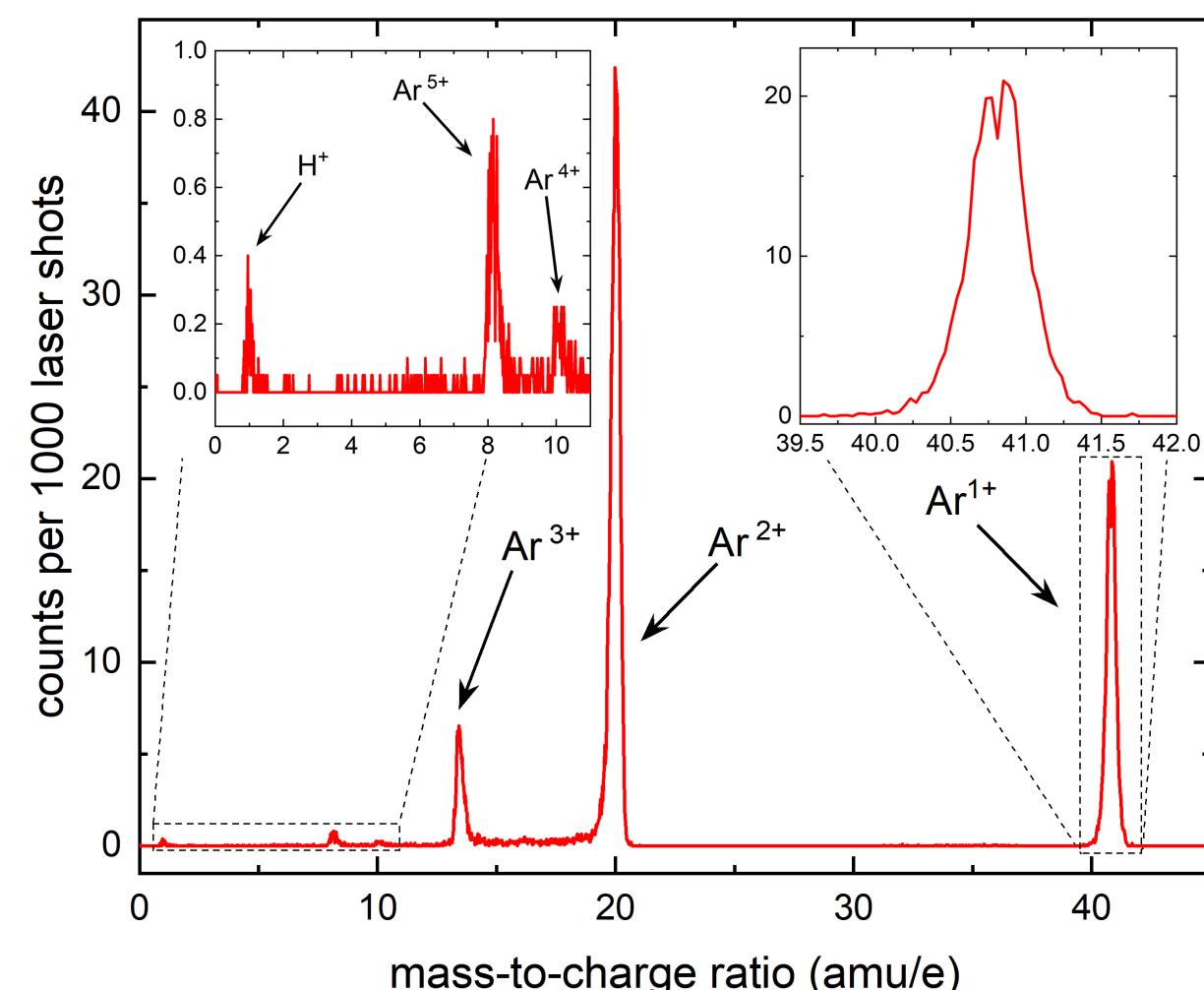


- 3 piezo motors allow *in-situ* alignment of upper electrode for height h and angular tilt $\phi_{x,y}$
- vacuum chamber backfilled with Argon gas at $p_0 = 9.0 \times 10^{-7} \text{ mbar}$

geometric boundaries

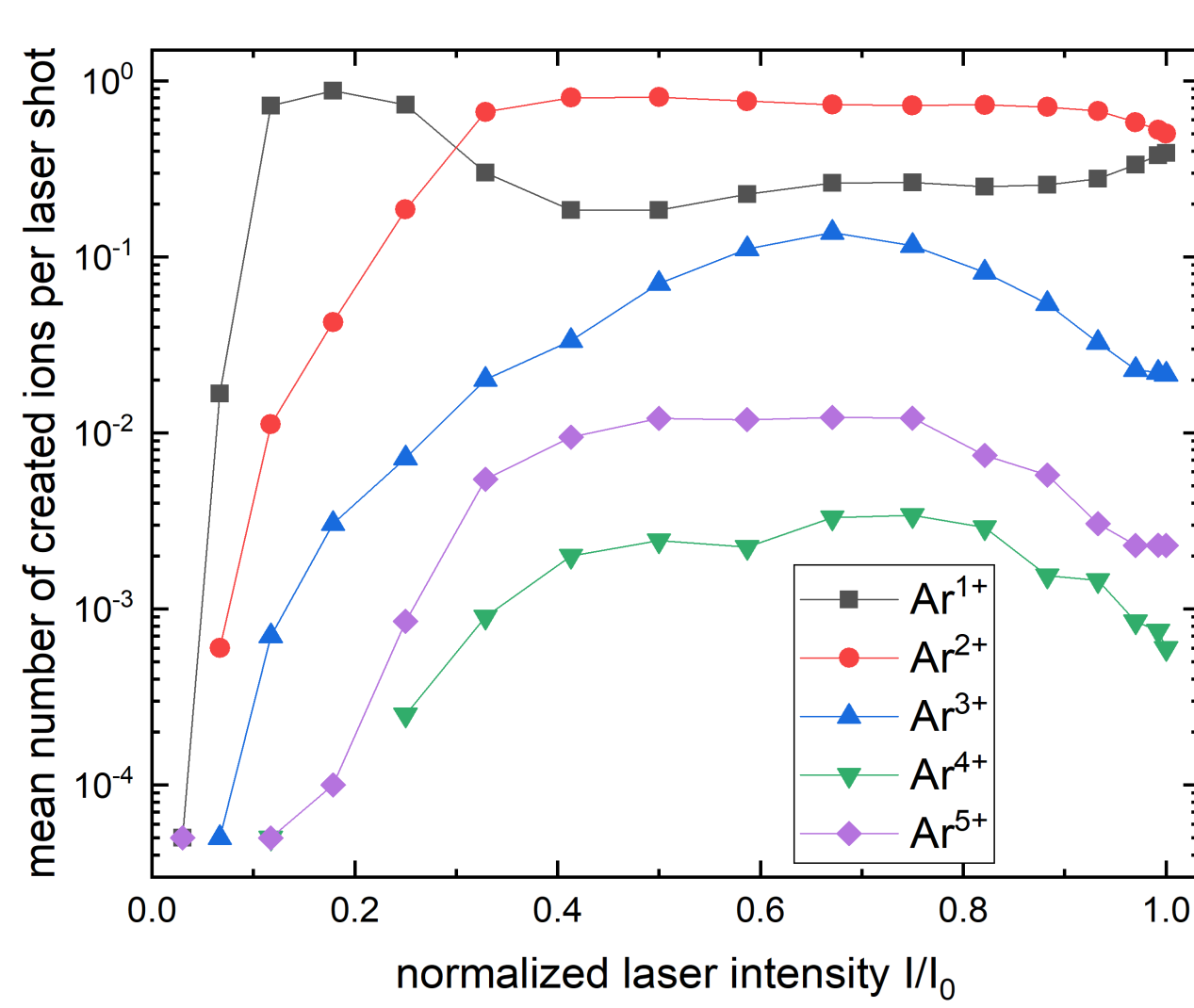


ion charge states

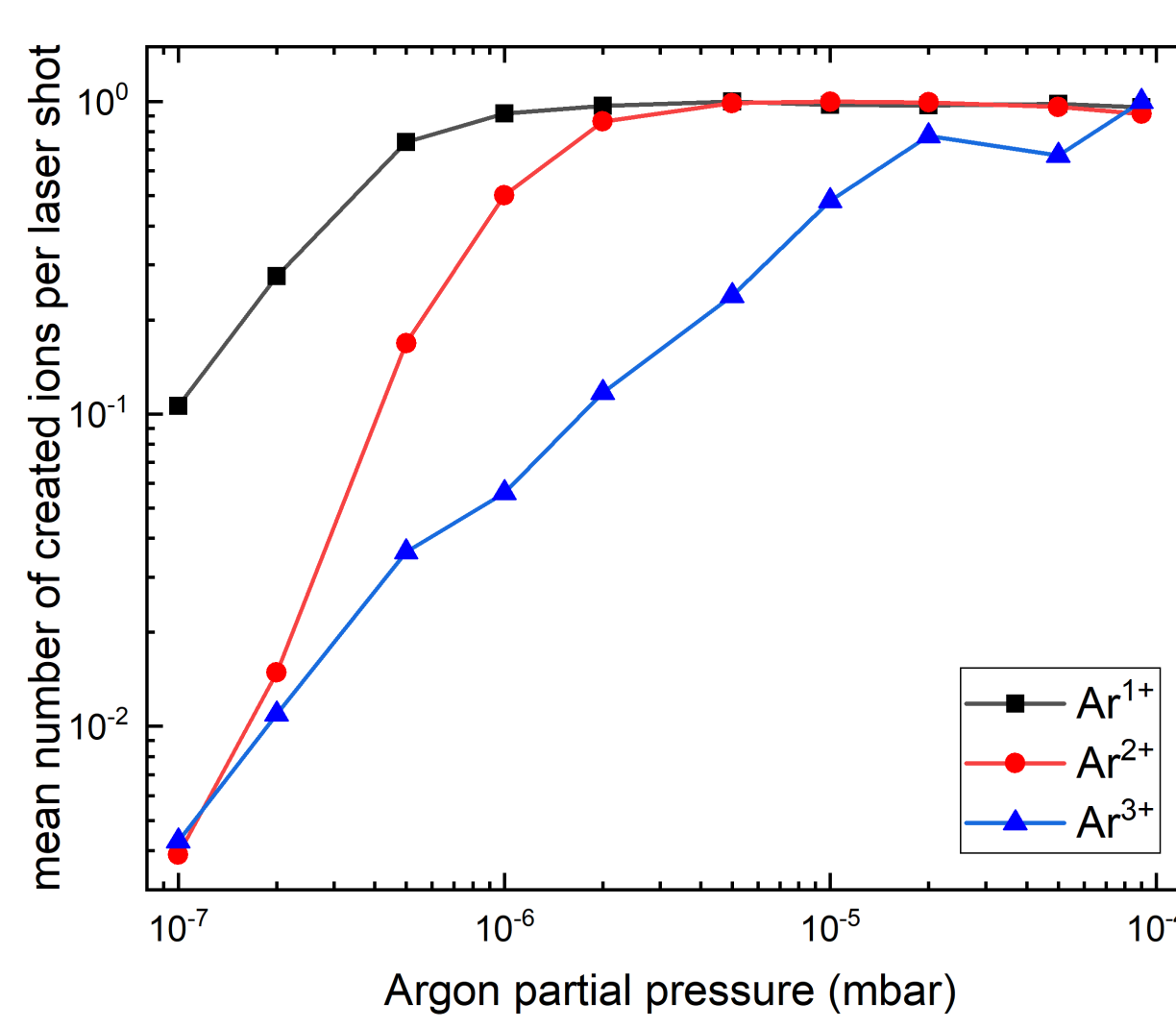


- no photoelectrons created within buncher geometry → ions only from photoionization
- creation of Argon ions Ar^{q+} with charge state $q = 1, \dots, 5$ accessible

created ions vs. intensity



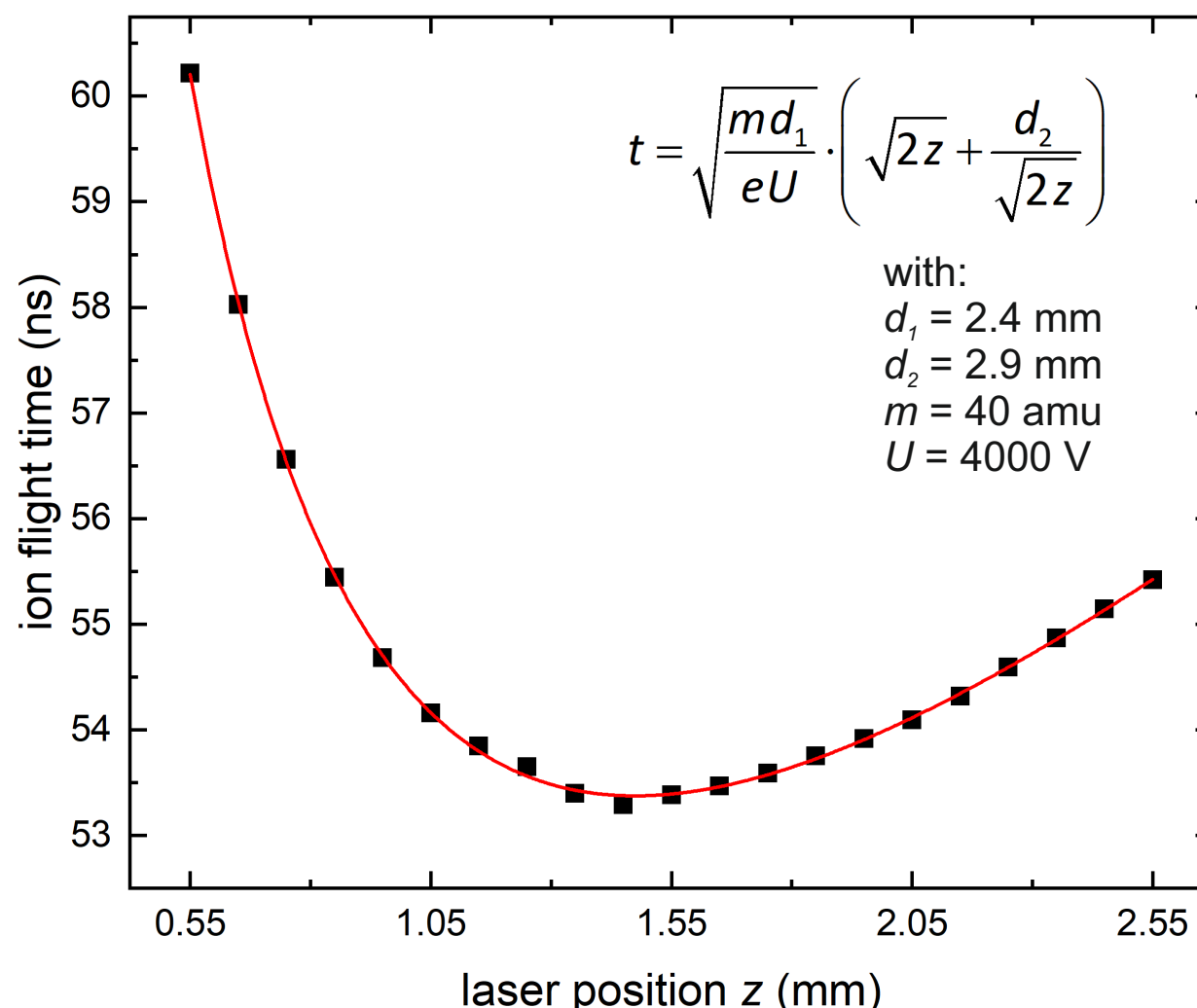
created ions vs. pressure



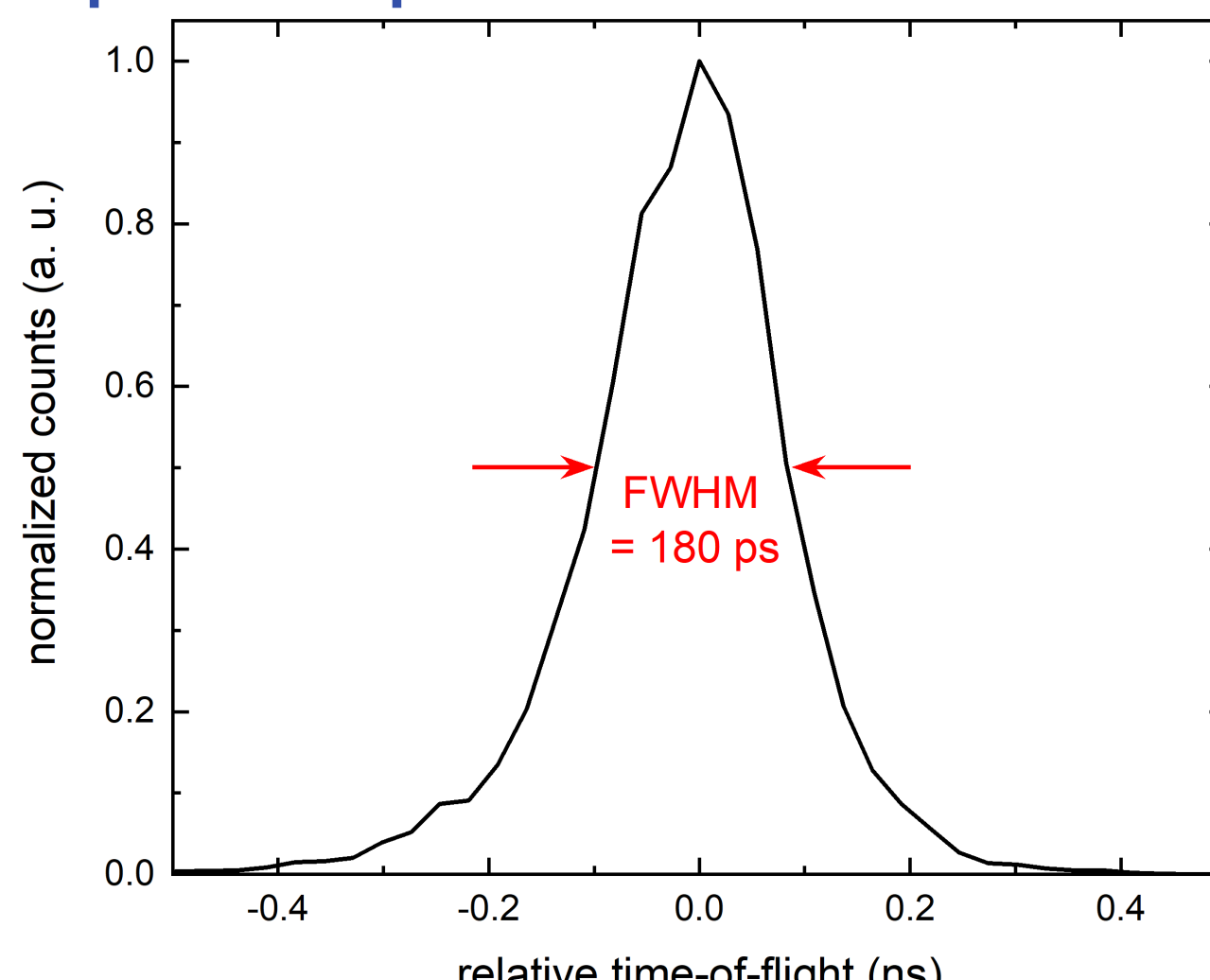
- charge state depends on the laser intensity, number of ions depends on number density
- ⇒ control over charge state and ion number via gas beam pressure and laser intensity

Flight time focus and 180 ps ion pulses

flight time vs. laser position



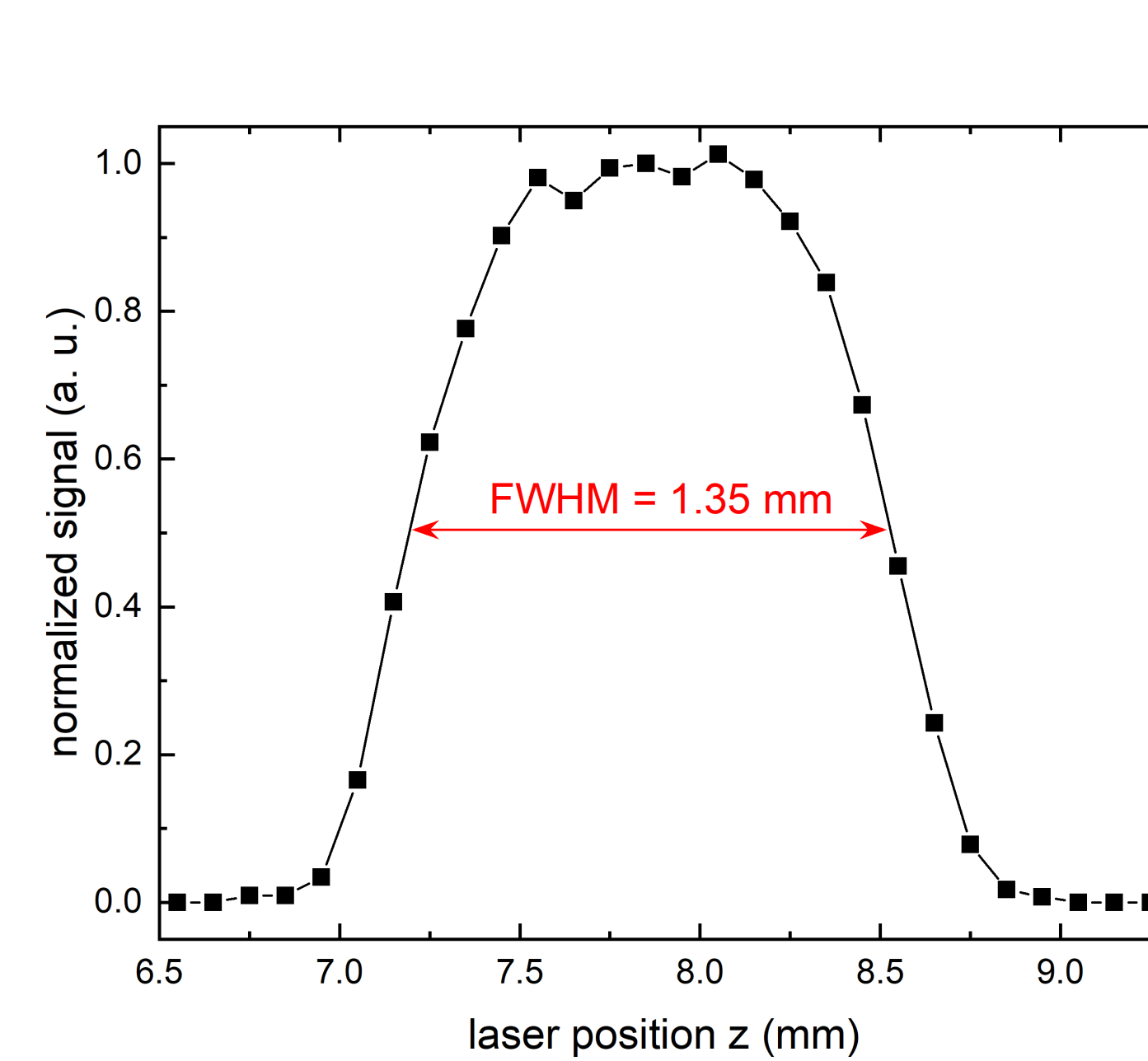
pulse shape



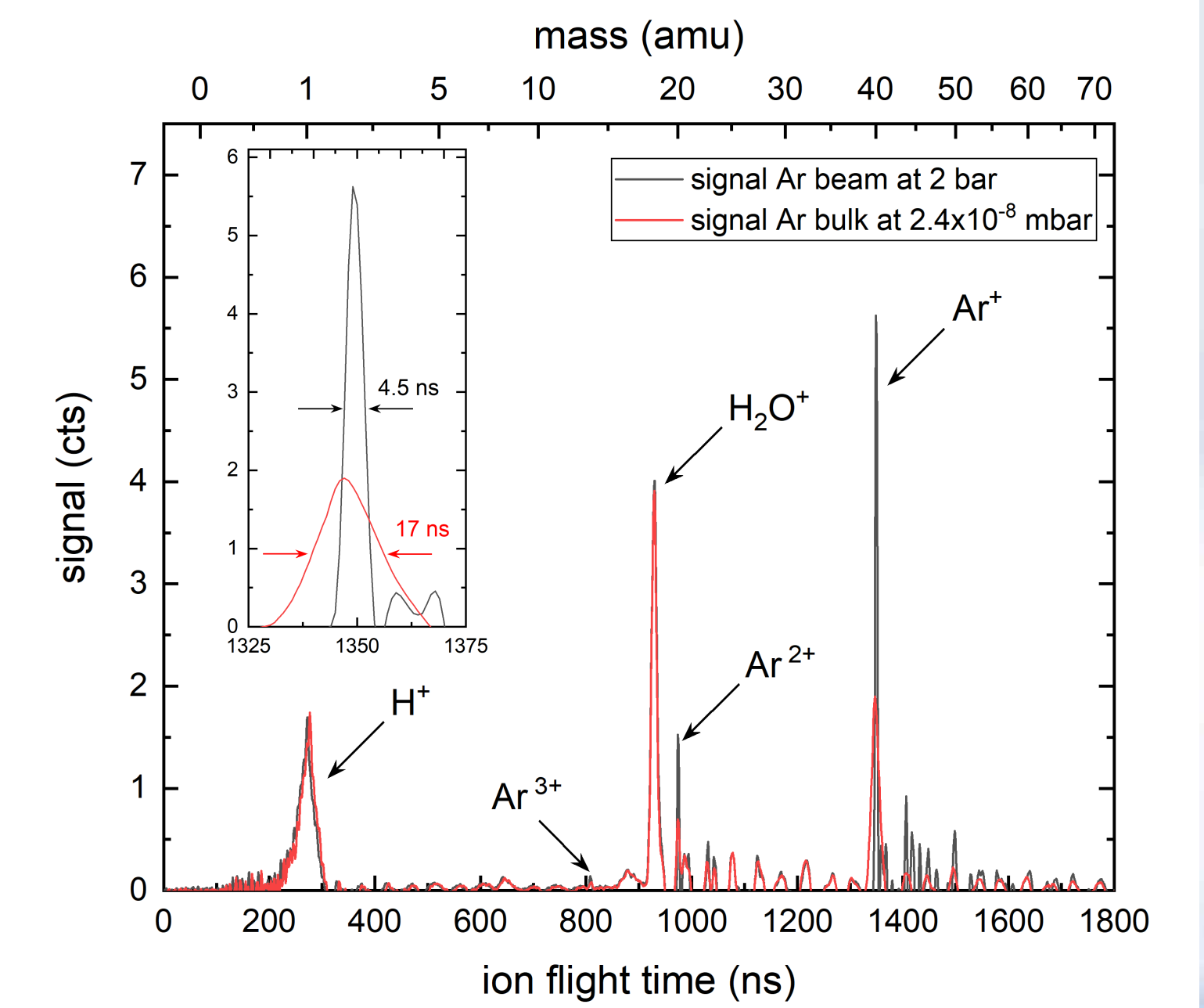
- shortest pulse duration yields a FWHM of 180 ps for the Ar^+ pulse of the backfilled gas
- flight time as a function of laser position matches the theoretically expected behaviour
- ⇒ allows to extract distances d_1 , d_2 and z_0 in geometric arrangement

Argon gas beam and sample measurements

Beam profile



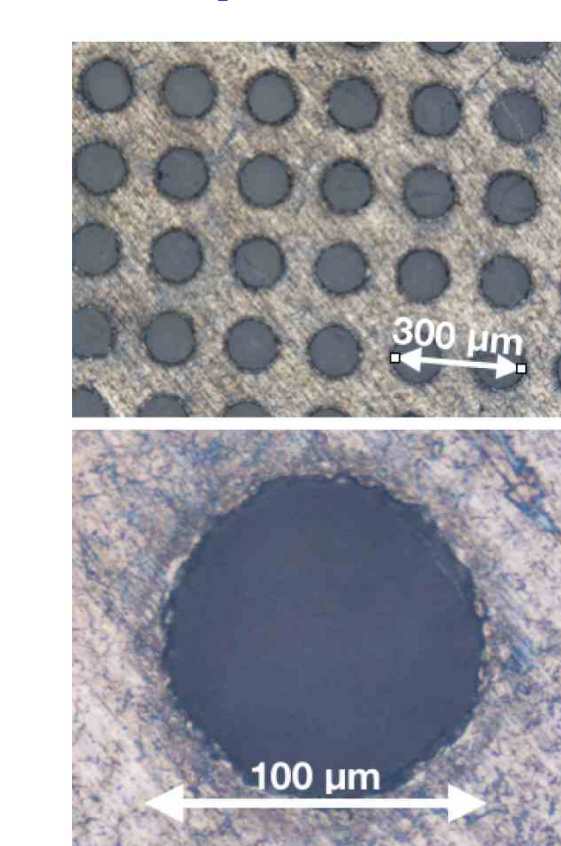
Comparison beam & bulk spectra



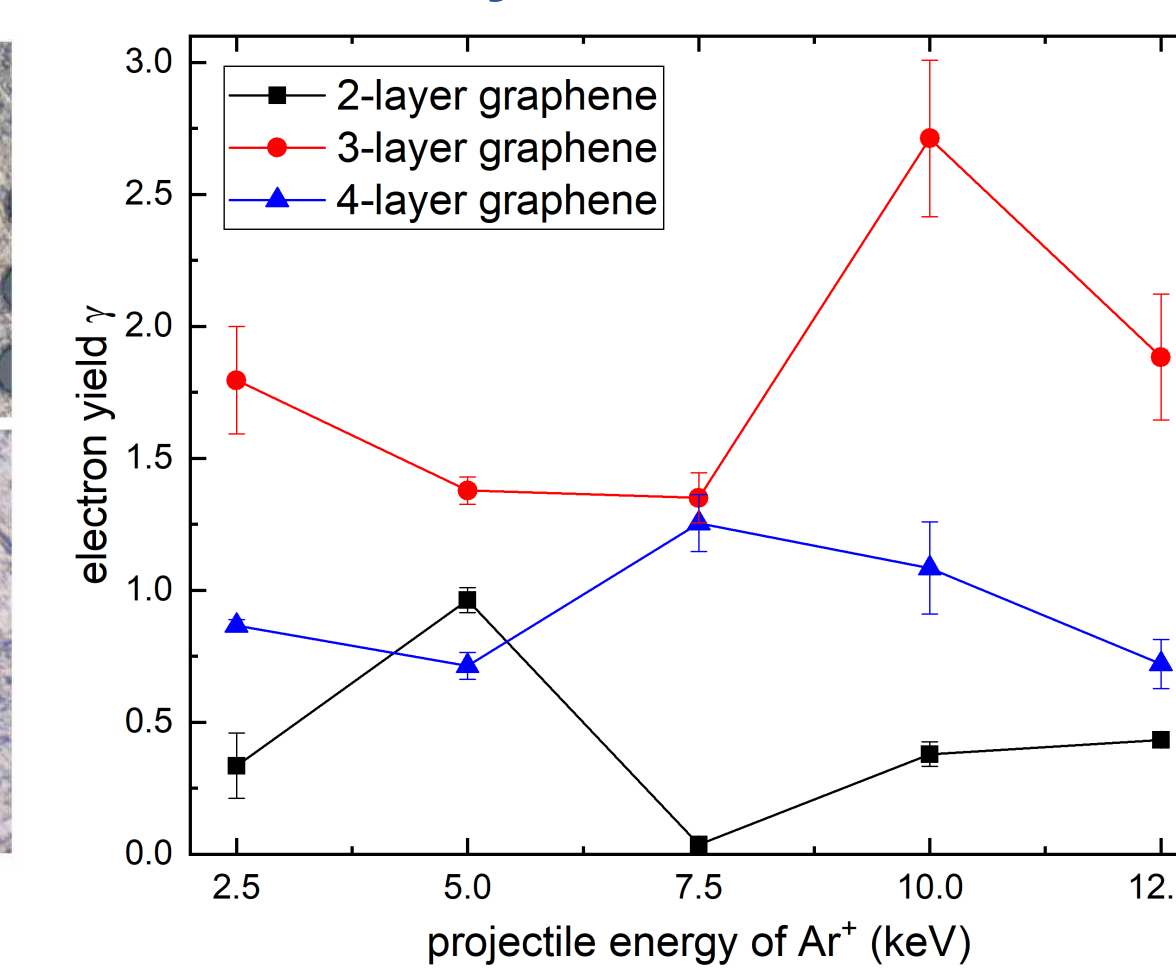
- symmetric profile of Argon beam at ionization point defined by aperture (skimmer) of $\varnothing 1 \text{ mm}$
- Argon ions Ar^{q+} with charge state $q = 1, 2, 3$ accessible at modest beam pressure of 2 bar
- clear difference of pulse widths between beam signal and bulk signal
- ⇒ thermal velocity distribution can be reduced drastically by cold molecular beam (below 1 K)

Measurements on graphene as a thin target for electron emission

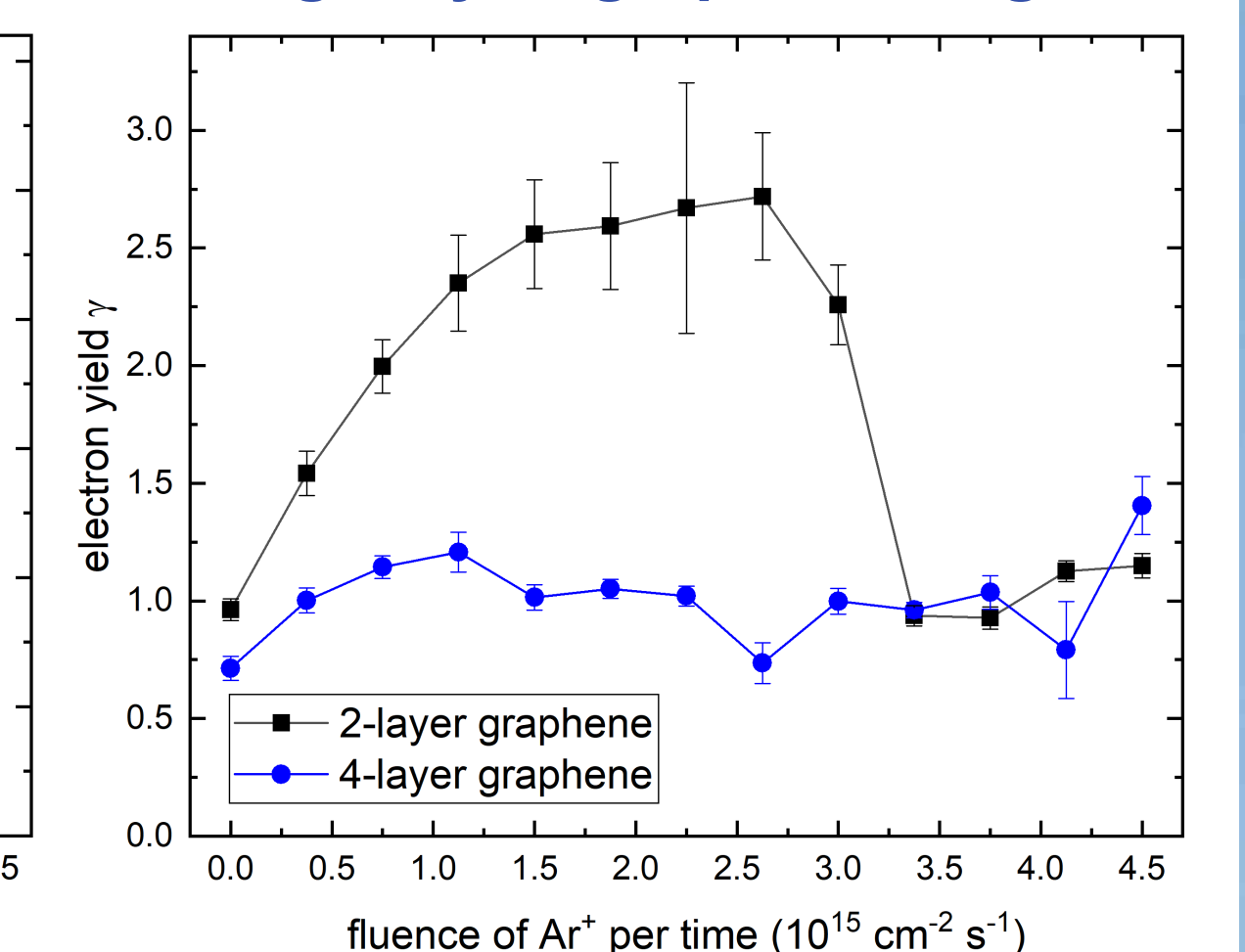
sample



electron yield in transmission



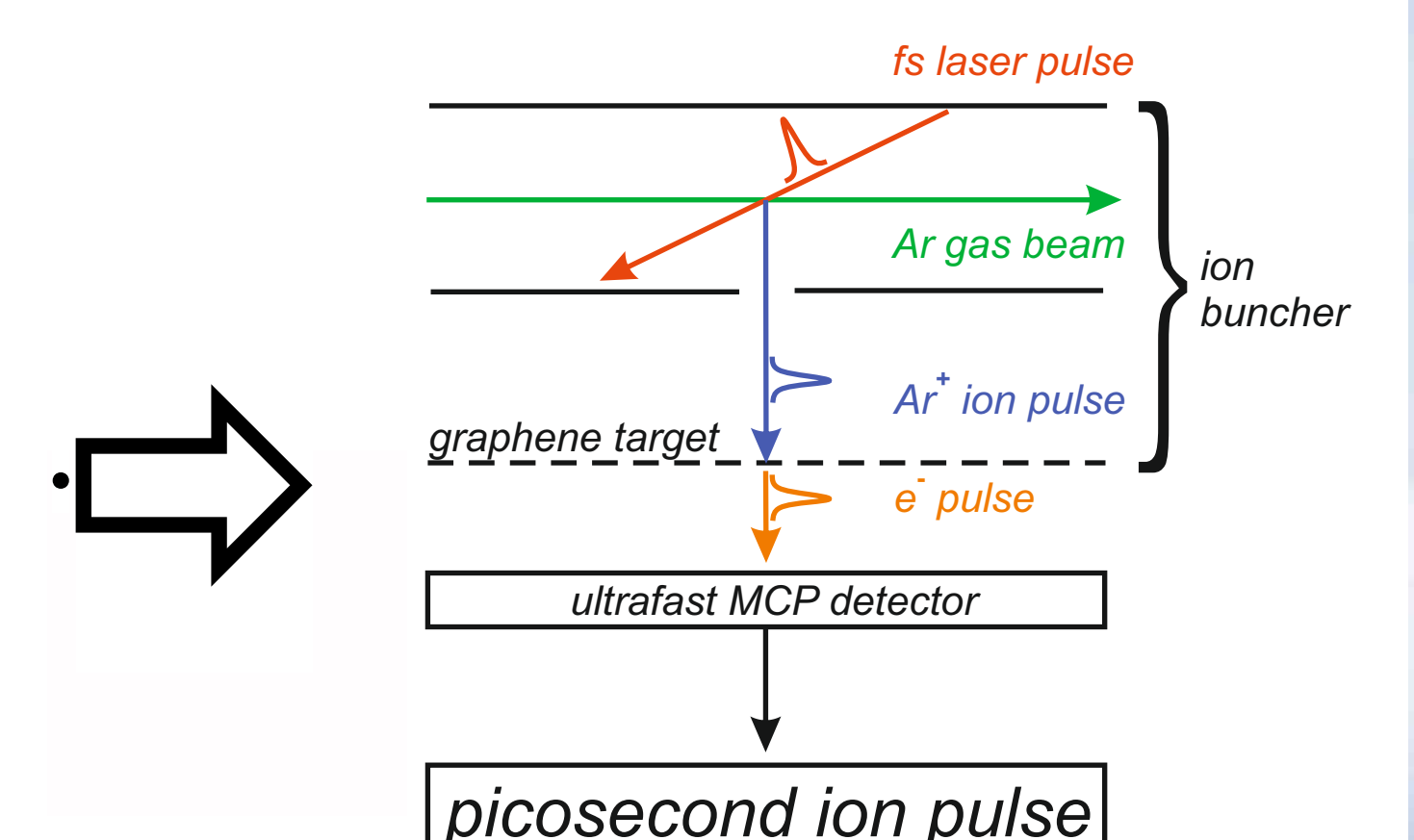
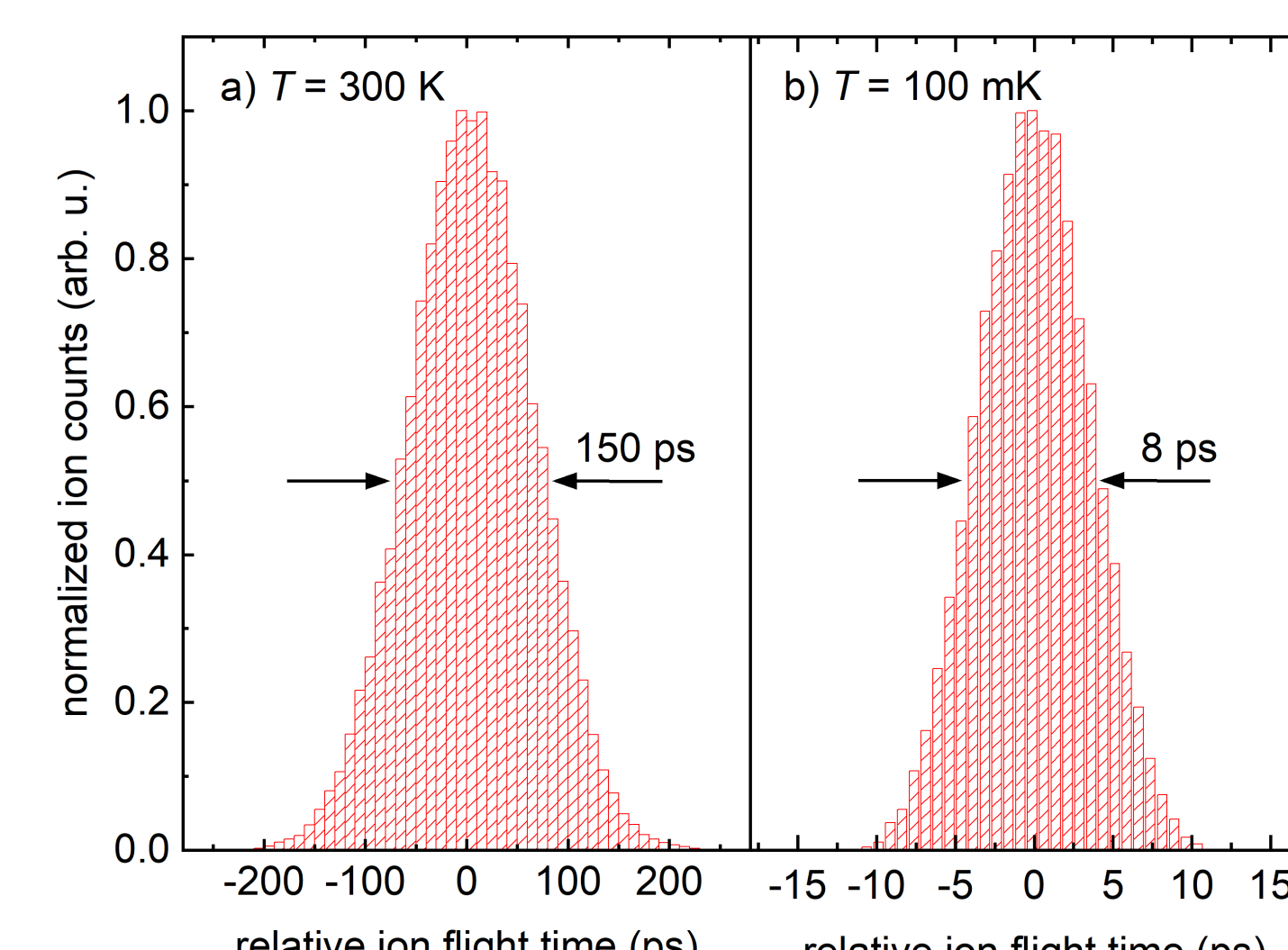
longevity of graphene target



- graphene samples are suitable to emit more than one electron on average for 2.5 - 12.5 keV Ar^+
- samples withstand a total fluence of up to $10^{15} \text{ ions/cm}^2$ → huge longevity for our application
- varying new substrates with different grid sizes to improve graphene stability & durability
- new technique to get rid of PMMA in the processing

Goal: ion source with picosecond time resolution

simulated pulse width for sub-Kelvin starting velocity distribution



- reduction of thermal velocity distribution allows to further compress ion pulses within buncher
- detection of ultrashort ion pulses possible via thin graphene target as electron emitter
- ⇒ combination of ion buncher with ultracold molecular beam leads to picosecond ion source!